IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: Takashi FUJITA et al. Art Unit: 1797

Application Number: 10/561,538 Examiner: Xiaoyun Xu

Filed: December 19, 2005 Confirmation Number: 9367

For: SPECIFIC COMPONENT MEASURING METHOD BY SPECTRAL

MEASUREMENT

Attorney Docket Number: 053362

Customer Number: 38834

RESPONSE UNDER 37 C.F.R. § 1.116 EXPEDITED PROCESSING REQUESTED

Mail Stop: AF June 10, 2010

Commissioner for Patents P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

This paper is filed in response to the Office Action dated March 3, 2010.

Remarks begin on page 2 of this paper.